

## Optical Diffraction in Chiral Smectic-C Liquid Crystals

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We report a study on the optical diffraction for light propagation perpendicular to the twist axis in the chiral smectic-C liquid crystal. In this phase grating mode, we find very unusual intensity and polarization features in the diffraction pattern. These observed features can be explained by invoking the theory of anisotropic gratings which takes into account the internal diffractions.

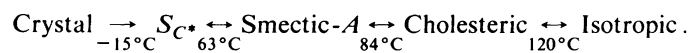
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The chiral smectic-C ( $S_{C^*}$ ) liquid crystal phase has a helical stack of layers of uniformly tilted molecules. The tilt of the molecules is coupled to the layer thickness producing local biaxiality in the medium. The chirality in the medium removes the mirror symmetry in the system leading to the possibility of sustaining an electric polarization  $\mathbf{P}$  (along the local twofold axis), spiraling uniformly about the twist axis of the helical structure. Meyer *et al.* [1] discovered the existence of ferroelectricity in  $S_{C^*}$ . Technologically,  $S_{C^*}$  became very important after Clark and Lagerwall [2] demonstrated the submicrosecond dynamics and other related properties like symmetric bistability, threshold behavior, and large electro-optic response that are exploited in the fast switching display devices. Further, studies on pyroelectricity [3], shear induced polarization [4], electroclinic effect [5], second harmonic generation [6], and other phenomena [7] have established the rich physical properties exhibited by  $S_{C^*}$ . In addition,  $S_{C^*}$  has many interesting optical properties. These arise due to the fact that in the successive layers, the local index ellipsoid (triaxial ellipsoid) spirals uniformly about the twist axis at a constant angle. The study of propagation of light in the Bragg reflection mode has shown some distinct optical polarization properties peculiar to this phase [8-11]. The study of propagation of light perpendicular to the twist axis is

equally interesting, but has drawn very little attention. In this geometry, the medium acts as a phase grating; i.e., a plane wave front incident on the sample becomes a periodically corrugated wave front inside the medium resulting in optical diffraction. So far, optical studies in this geometry have been largely confined to the determination of the pitch of the structure [12]. We have undertaken a study of the propagation of light in  $S_{C^*}$  in the phase grating mode in all its details.

In this Letter, we report for the first time some unusual features of diffraction associated with the phase grating mode in  $S_{C^*}$ . We observed that in a range of sample thicknesses, the diffracted light in all the orders was preferentially polarized parallel to the twist axis. Further, in thicker samples, although the above features were seen at lower temperatures, at higher temperatures the diffracted light in all the orders was nearly polarized perpendicular to the twist axis. These observed features contradict the predictions of the Raman-Nath theory of phase gratings [13] as extended to  $S_{C^*}$  [14] where the wave front corrugations inside the medium are ignored. It is shown here that a rigorous theory of anisotropic dielectric gratings as developed by Rokushima and Yamakita (RY) [15] can account for our observed features.

The experiments were carried out on the commercially obtained sample BDH SCE-6. This has the following sequence of transitions:



To get monodomain samples suitable for phase grating geometry, the following procedure was employed: Sample cells were prepared using glass plates which were previously treated with polyimide and rubbed in the parallel direction. Cells of thicknesses 23, 50, 125, and 250  $\mu\text{m}$  were obtained using Mylar spacers. Later, the cells were filled with the sample in the isotropic phase and then cooled very slowly through the cholesteric to smectic- $A$  ( $S_A$ ) phase in the presence of a magnetic field of strength 2.4 T applied parallel to the rubbed direction of the glass plates. In the  $S_A$  phase, the field was removed. Observations under a Leitz polarizing microscope revealed the formation of a very good homogeneous monodomain  $S_A$  phase which on further slow cooling transformed to the  $S_{C^*}$  phase. In  $S_{C^*}$  we got a pattern having uniform

parallel striations (fringes). The striations were perpendicular to the rubbed direction of the glass plates and were parallel to the smectic layers. They arise due to a uniformly twisted stack of layers (of tilted molecules) with the twist axis along the rubbed direction. The fringe width corresponds to the pitch of the helical structure [12]. In SCE-6, the pitch varies from about 4 to 6  $\mu\text{m}$  in the temperature range of 25  $^\circ\text{C}$  to 60  $^\circ\text{C}$ . For samples of thicknesses much lower than 23  $\mu\text{m}$ , due to the surface effects, the helical structure got considerably distorted and hence was not used. In the experimental setup, the cell was kept on the central table of a goniometer which had a 2 mW He-Ne laser ( $\lambda = 0.6328 \mu\text{m}$ ) on the fixed arm. The light was allowed to fall normally on the sam-

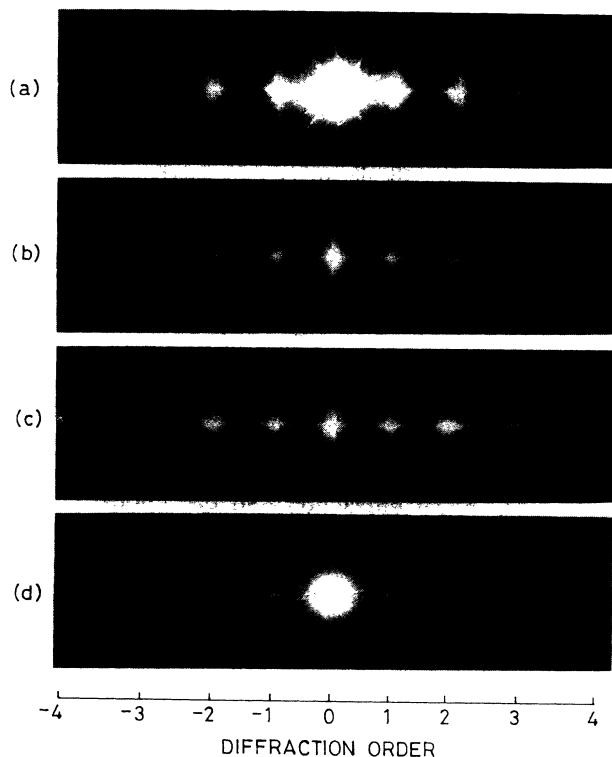


FIG. 1. The photographs of the diffraction pattern of a  $50\ \mu\text{m}$  sample at room temperature ( $\approx 25^\circ\text{C}$ ) in (a)  $HH$ , (b)  $HV$ , (c)  $VH$ , and (d)  $VV$  geometries. One may note that in (c) the second order is more intense than the first order. Such effects are characteristic of phase gratings. In  $S_{C^*}$ , they are sensitive to temperature.

ple cell. The diffracted light was collected on a photodiode mounted on the moving arm and measured with a Keithley 181 nanovoltmeter. Simultaneously the signal was fed into a Graphtec servocorder.

In our experiments, for incident linearly polarized light, we got sharp diffraction spots. Typically there were 6 to 7 orders on either side of the direct beam. Figure 1 shows one such diffraction pattern in the geometries  $HH$ ,  $HV$ ,  $VH$ , and  $VV$ . ( $H$  denotes linear polarization parallel to the twist axis and  $V$  denotes linear polarization perpendicular to the twist axis. The first symbol indicates the state of polarization of the incident light and the second symbol indicates the polarization state in which the diffracted beam was analyzed.)

Figure 2 shows the measured diffracted intensity in the various orders (except the zeroth order) for 50 and 250  $\mu\text{m}$  sample thicknesses. Surprisingly, the intensity in the  $HH$  geometry (open circles) is very much higher than the intensity in the  $HV$  geometry (closed circles) for all orders. Also the intensity in the  $VH$  geometry (open squares) is higher than that in the  $VV$  geometry (closed squares). That is, in all these orders, the diffracted light is nearly linearly polarized parallel to the twist axis. Interestingly, this behavior is observed in samples of thick-

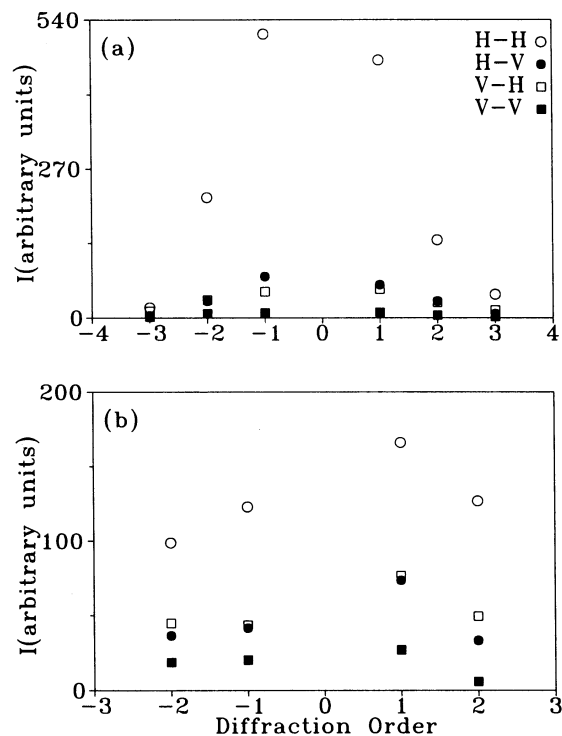


FIG. 2. The intensity  $I$  (arbitrary units) in the diffraction orders shown for various geometries for two samples: (a) thickness =  $50\ \mu\text{m}$  and temperature =  $50.6^\circ\text{C}$ ; (b) thickness =  $250\ \mu\text{m}$  and temperature =  $45.5^\circ\text{C}$ . Here one may notice that in every order  $I(HH) > I(HV)$  and  $I(VH) > I(VV)$ . The intensity of the direct beam is too high to be shown here. The asymmetry in the intensity pattern for some orders is due to slight imperfections in the orientation of the sample.

ness 23 and  $50\ \mu\text{m}$  at all temperatures. For  $125\ \mu\text{m}$  the same behavior is also seen at all temperatures except in the neighborhood of the  $S_{C^*}$ - $S_A$  transition. However, in the sample with a thickness of  $250\ \mu\text{m}$ , a more interesting behavior is found. At temperatures  $\lesssim 46^\circ\text{C}$  the intensity and polarization features are the same as that described above. But at higher temperatures, the behavior gets completely reversed. This is shown in Fig. 3. Here the intensity of the diffracted light in the  $VV$  geometry becomes more intense than the intensity in the  $VH$  geometry. Also the intensity in the  $HV$  geometry is more than that in the  $HH$  geometry; i.e., in this case, in all these orders, the component of the diffracted light perpendicular to the twist axis is more than the component parallel to the twist axis. However, in all these geometries, in all the samples, the zeroth order is in a polarization state close to that of the incident vibration. We have shown data on two samples [Figs. 2(a) and 3] of different thicknesses (50 and  $250\ \mu\text{m}$ ) but at the same temperature ( $50.6^\circ\text{C}$ ) to highlight their contrasting behavior.

The above results cannot be accounted for by the

theory [14] of the optical diffraction in  $S_C^*$  which assumes that in the corrugated wavefront, inside the medium, the amplitude of the corrugation is much smaller than the wavelength of the corrugation; i.e., the internal diffractions are ignored. This assumption is valid only in the limit of low birefringence and small thickness. However, in the present case, the material has a high birefringence and the sample thicknesses are large. Hence we have used a more rigorous theory of anisotropic dielectric gratings due to RY [15] which incorporates the internal diffractions within the medium.

Following RY [15] and Galatola, Oldano, and Sunil Kumar [16], the Maxwell equations are written in the form

$$\Psi(z) = \exp(ik_0zD)\Psi(0), \tag{1}$$

where

$$\Psi = (E_x H_y E_y H_z)^t$$

and

$$k_0 = 2\pi/\lambda.$$

$$D = \begin{bmatrix} 0 & I & 0 & 0 \\ \epsilon_{xx} - \epsilon_{xz}\epsilon_{zz}^{-1}\epsilon_{xz} - Q^2 & 0 & \epsilon_{xy} - \epsilon_{xz}\epsilon_{zz}^{-1}\epsilon_{zy} & -\epsilon_{xz}\epsilon_{zz}^{-1}Q \\ -Q\epsilon_{zz}^{-1}\epsilon_{zx} & 0 & -Q\epsilon_{zz}^{-1}\epsilon_{zy} & I - Q\epsilon_{zz}^{-1}Q \\ \epsilon_{yx} - \epsilon_{yz}\epsilon_{zz}^{-1}\epsilon_{zx} & 0 & \epsilon_{yy} - \epsilon_{yz}\epsilon_{zz}^{-1}\epsilon_{zy} & -\epsilon_{yz}\epsilon_{zz}^{-1}Q \end{bmatrix}.$$

Here,  $\epsilon_{xz}$ , etc. are themselves infinite square matrices. The  $ij$ th element of the matrix  $\epsilon_{xz}$ , etc. is the  $(i-j)$ th Fourier component of the  $\epsilon_{xz}$ , etc. element of the dielectric tensor  $\epsilon$ .  $Q$  is an infinite diagonal matrix with elements  $q_0 + nq$ , where  $q_0$  is the incident wave vector in the bounding isotropic medium and  $q$  is the grating wave vector with  $n$  going from  $-\infty$  to  $\infty$ ;  $I$  is the infinite unit matrix.

To compare the theory with the experimental results it is convenient to work in terms of the modes in the bounding isotropic media. If  $\Phi$  is a vector whose components are the strengths of the different modes in the bounding isotropic media, then Eq. (1) becomes

$$\Phi(z) = S\Phi(0), \tag{2}$$

where  $S$  is the scattering matrix whose components are functions of the material parameters. The vector  $\Phi(0)$  contains the reflected  $\Phi_r$  and incident  $\Phi_i$  components, while  $\Phi(z)$  contains the transmitted component  $\Phi_t$  [16]. A suitable rearrangement in the elements of the  $\Phi$  vector leads to

$$\Phi_r = \mathcal{R}\Phi_i, \quad \Phi_t = \mathcal{T}\Phi_i, \tag{3}$$

where  $\mathcal{R}$  and  $\mathcal{T}$  are the backward and forward scattering matrices, respectively.

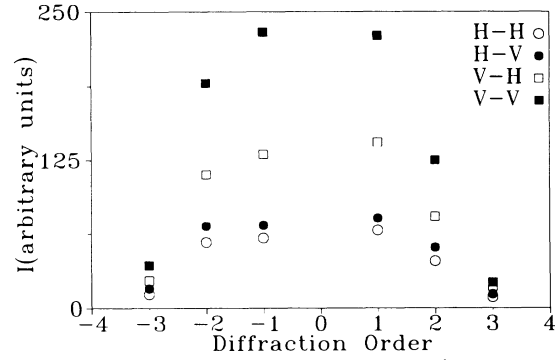


FIG. 3. The intensity  $I$  (arbitrary units) in the diffraction orders shown for various geometries for a  $250 \mu\text{m}$  sample at  $50.6^\circ\text{C}$ . One may notice that in every order  $I(HH) < I(HV)$  and  $I(VH) < I(VV)$ .

$E_x$ ,  $E_y$ ,  $H_x$ , and  $H_y$  are infinite column matrices containing the various Fourier components of the transverse fields and  $\lambda$  is the wavelength of light. The propagation matrix  $D$  for our problem simplifies to an infinite square matrix:

It was sufficient to have the Fourier components up to  $n=5$  in the dielectric tensor and also to assume local uniaxiality. Computations with higher Fourier components and biaxiality did not alter our main results. Figure 4 shows the computed results. Here the intensity of the first order is depicted as a function of sample thickness in the different geometries. The intensity in the  $HH$  geometry, in the thickness range  $50$  to  $200 \mu\text{m}$ , is more than that in the  $HV$  geometry [Fig. 4(a)], whereas the intensity in the  $VH$  geometry is throughout more than that in the  $VV$  geometry [Fig. 4(b)]. This is in accordance with the observed results shown in Fig. 2. Further, Fig. 4(a) shows that around  $250 \mu\text{m}$  the intensity behavior in the  $HH$  and  $HV$  geometry can get reversed. This explains the contrasting behavior in the  $HH$  and  $HV$  geometries of the  $250 \mu\text{m}$  sample at  $45.5^\circ\text{C}$  [Fig. 2(b)] and at  $50.6^\circ\text{C}$  (Fig. 3). However, the observed results in  $VV$  and  $VH$  geometries of the  $250 \mu\text{m}$  sample at  $50.6^\circ\text{C}$  are not in accordance with the computed results shown in Fig. 4(b). Also, our observed results for  $23 \mu\text{m}$ , at all temperatures, show the  $HH$  component to be greater than the  $HV$  component and this is not in accordance with the result shown in Fig. 4(a). It may be pointed out that the computations shown in Fig. 4 are for one set of material parameters. These parameters are sensitive functions of

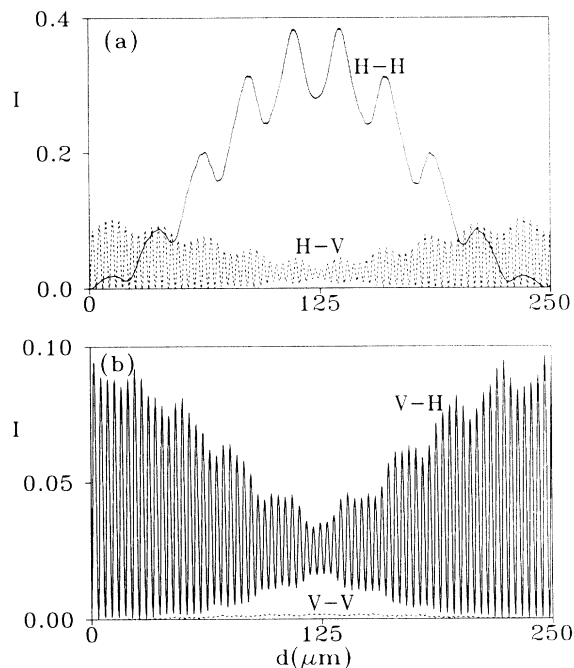


FIG. 4. The normalized intensity  $I$  as a function of sample thickness  $d$  ( $\mu\text{m}$ ) for different geometries in the first order. In these computations, the following material parameters of SCE-6 have been used: birefringence=0.18, pitch= $5\ \mu\text{m}$ , and tilt angle= $18^\circ$ .

the temperature. It was found that the theory can yield qualitatively all the above observed results by a proper choice of material parameters. Also, the computations show that the RY theory can account for the observed polarization features of the zeroth order as well as those of the higher diffraction orders.

The other interesting feature in Fig. 4 is the appearance of modulations. These modulations in the diffracted intensity can be interpreted as being due to the different orders of scattering. This can be shown by using a perturbation theory [16] where the  $z$ -dependent (the propa-

gation direction) part of the dielectric tensor is treated as a perturbation over an effective anisotropic homogeneous medium.

In conclusion, we have experimentally studied, for the first time, the polarization and intensity features of the diffraction in the phase grating mode in  $S_C^*$ . The observed results are very surprising and interesting and these can be accounted for on the basis of the RY theory.

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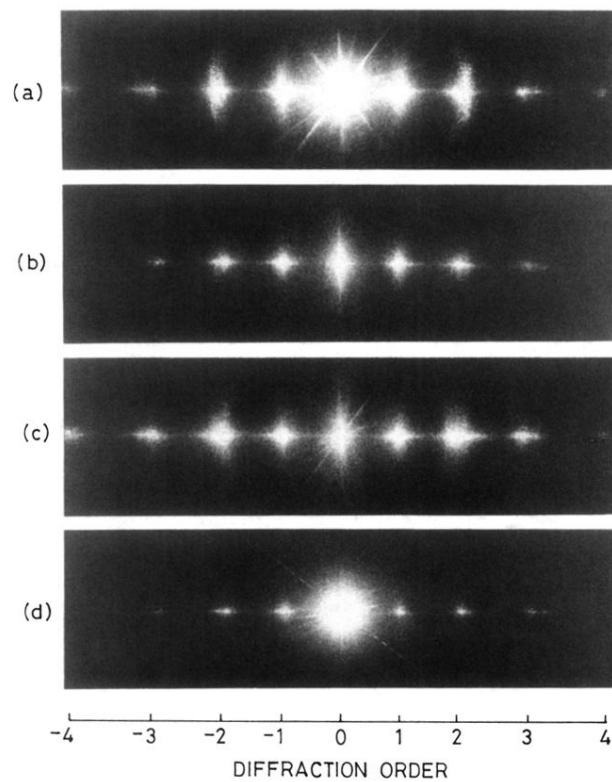


FIG. 1. The photographs of the diffraction pattern of a  $50\ \mu\text{m}$  sample at room temperature ( $\approx 25^\circ\text{C}$ ) in (a)  $HH$ , (b)  $HV$ , (c)  $VH$ , and (d)  $VV$  geometries. One may note that in (c) the second order is more intense than the first order. Such effects are characteristic of phase gratings. In  $S_C^*$ , they are sensitive to temperature.